

## **LXT400**

#### All Rate Extended Range Switched 56/DDS Transceiver

#### **Datasheet**

## **General Description**

The LXT400 is an integrated line interface circuit for Switched 56 (SW 56) and Digital Data Service (DDS), compatible with any combination of 19 to 26 AWG cable. The LXT400 operates at any of 17 preset data rates from 2.4 kbps to 72.0 kbps, providing appropriate transmit pulse shaping, receive signal detection and timing recovery at the metallic interface between the carrier and the customer installation. The LXT400 offers a variety of diagnostic features including loopback, line status and equalizer monitor outputs, while conforming to AT&T, ANSI and Bellcore specifications.

The LXT400 transmit section includes switched capacitor filters, continuous reconstruction filters, and a 50% AMI encoder. The AMI pulse is synchronized with the transmit clock.

The LXT400 receive section performs line equalization, data extraction and timing recovery. The LXT400 has a BER of less than 10<sup>-7</sup> with up to 49 dB of cable attenuation at the Nyquist frequency for 56, 64 and 72 kbps, and 40 dB at the lower rates. The LXT400 is an advanced CMOS device which requires only a single +5 V power supply.

### **Product Features**

- Enhancements:
  - —Three new data rates: 38.4, 51.2, and 64.0 kbps
  - Improved accuracy in line attenuation reporting
  - —Simplified transmit digital timing
- Integrated transmitter, receiver and timing recovery on a single CMOS chip
- Transparent to framing and coding
- Receive equalizer filters allow data recovery from signals with up to 40 dB of attenuation at the Nyquist frequency at line rates below 56 kbps, and up to 49 dB at the 56, 64 and 72 kbps line rates

- Single 4.096 MHz crystal or master clock input
- Digital back-end loopback (CSU Loopback)
- Equalizer output monitor pin
- Line status (loop length, RLOS, etc.) information available for maintenance purposes
- Low power consumption (200 mW typical)
- Available in 28-pin plastic DIP and PLCC

Order Number: 249027-001

January 2001

■ Single 5 V only CMOS technology



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# Revision History

Revision	Date	Description



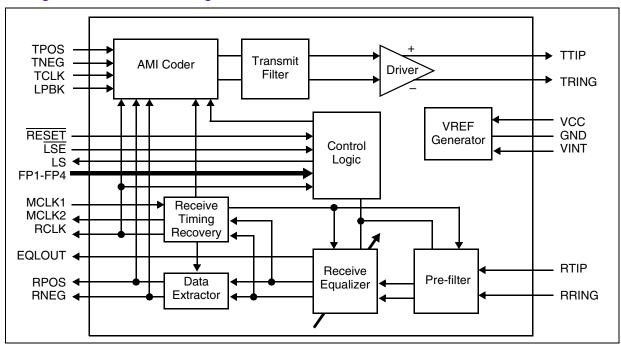


Figure 1. LXT400 Block Diagram



## 1.0 Pin Assignments And Signal Descriptions

Figure 2. LXT400 Pin Assignments

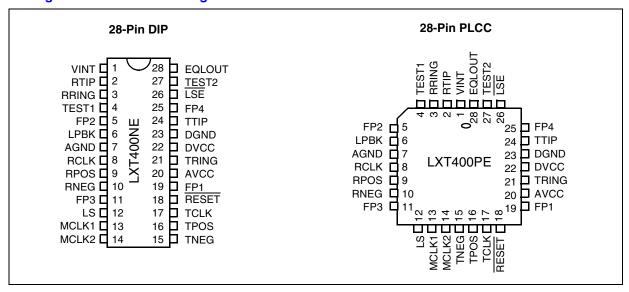


Table 1. LXT400 Signal Descriptions

Pin #	Sym	I/O	Description			
1	VINT	I	Intermediate Voltage Reference. Reference voltage used for internal analog circuits. This pin must be connected through a $1k\Omega$ resistor (Rv) to the center node between the two termination resistors, Rr, as shown in Figure 9 and Figure 10.			
2	RTIP		Receive Tip and Receive Ring. Receive data input pair. RTIP and RRING are a fully			
3	RRING	'	differential input for the receive line interface.			
4	TEST1	I	Test 1. Factory Test Pin. Do not connect.			
19	FP1	I				
5	FP2	- 1	Frequency Programming Inputs 1 through 4. The LXT400 data rate is set by the logic			
11	FP3	- 1	levels present at the FP1 through FP4 inputs as shown in Table 2. For operation at 38.4, 51.2, and 64.0 kbps, the RCLK output must be applied to the FP3 input.			
25	FP4	1				
6	LPBK	I	Loopback. When set High, activates digital back-end loopback.			
7	AGND	-	IC Ground. Ground for all IC circuitry except the transmit driver.			
8	RCLK	0	<b>Recovered Clock.</b> Clock recovered from signal input at RTIP and RRING, based on the data rate setting on the FP1 - FP4 inputs.			
0	DDOC	0	Receive Data Positive and Negative. Receive data outputs. A signal on RPOS corresponds			
10			to receipt of a positive pulse on RTIP and RRING. A signal on RNEG corresponds to a negative pulse on RTIP and RRING. Both outputs transition on the rising edges of RCLK, and			
10	RNEG	0	are never High simultaneously.			
12	LS	0	<b>Line Status Output.</b> A 16-bit serial word indicating activation state, line loss, and loss of signal (LOS). LS transitions occur on falling edges of RCLK. LS goes to a high impedance state when LSE is High. If LSE is tied Low, the LS output represents LOS only.			



Table 1. LXT400 Signal Descriptions (Continued)

Pin #	Sym	I/O	Description				
13 14	MCLK1 MCLK2	I 0	Master Clock 1 and Master Clock 2. The required 4.096 MHz master clock may be provided by a crystal connected across these pins, or by a digital clock connected to MCLK1. If a clock is provided on MCLK1, MCLK2 must be left unconnected.				
			Transmit Data Negative and Positive. These inputs are sampled on the falling edges of TCLK. AMI pulses are encoded as follows:				
15	TNEG	1	TPOS TNEG Transmit Signal				
16	TPOS	l i	0 0 Space				
			0 1 Negative Pulse				
			1 0 Positive Pulse 1 1 Space				
17	TCLK	I	Transmit Clock. Transmit clock at the data rate set by the FP1 - FP4 inputs.				
18	RESET	I	Reset. Hardware reset pin. Must be pulsed Low on power-up to initialize all internal circuits. Must also be pulsed Low after changing the data rate setting, and after forcing or releasing any loopback condition.				
20	AVCC	-	IC Power. Power supply for all IC circuits except the transmit driver. +5 V (±5%).				
21	TRING	0	ransmit Ring and Transmit Tip. Differential driver outputs. Designed to drive the 135Ω				
24	TTIP	0	isted-pair cable through the transmit line interface shown in application diagrams (Figure 9 and Figure 10).				
22	DVCC	-	<b>Driver Power.</b> Transmit driver power supply. +5 V (±5%). Tie to AVCC, pin 20.				
23	DGND	-	Driver Ground. Transmit driver ground. Tie to AGND, pin 7.				
26	LSE	I	Line Status Enable. Active Low enable for the LS serial port. This pin must transition from High to Low to read LS serial data. LSE is sampled on the rising edges of RCLK.				
27	TEST2	I	Test 2. Analog test pin. Must be tied to ground.				
28	EQLOUT	0	Equalizer Output Monitor. Monitors Equalizer. Must be left open when not used.				



## 2.0 Functional Description

#### 2.1 Introduction

The LXT400 comprises three basic sections: transmit, receive, and control logic.

The transmit section includes a 50% AMI encoder, a programmable switched-capacitor low-pass filter, a low-pass notch filter, a transmit timing re-synchronizer, and a continuous reconstruction filter. An on-chip CMOS driver is also incorporated to drive a  $135\Omega$  line through a transformer.

The receive section includes pre-filters and line equalizers, and the timing recovery and data extraction blocks. An internal digital phase locked loop (DPLL) is used in conjunction with the MCLK input to synchronize the recovered clock and data.

The control logic block initializes the transceiver, selects receive filters and reports status information on the serial port. Control logic inputs FP1 through FP4 determine the data rate as specified in Table 2. The control logic executes the initialization procedure upon automatic resynchronization or external RESET. Filter selection optimizes the receive signal-to-noise ratio (SNR) by matching the filter in the equalizer section to the strength of the received signal (a function of loop length/line loss). The control logic block also reports receiver status, estimated line length (as indicated by filter selection) and a receive loss of signal (RLOS) alarm on the serial port.

#### 2.2 Initialization

Upon power-up, or after changing the baud rate or loopback condition of the line interface, a RESET pulse is required to initialize the LXT400. On receipt of the RESET pulse, the LXT400 executes an iterative cycle of level detection and offset cancellation to select the appropriate equalizer settings for the received signal. Receiver initialization can be monitored on the serial channel. When received data has a 50% ones density, full operation is achieved within one second after RESET. Under the minimum ones density condition specified in Table 3, full operation is achieved within eight seconds after RESET. Correct initialization assumes the presence of an AMI-coded signal at the RTIP and RRING inputs. The LXT400 will not correctly initialize unless a stable signal which meets the network interface specifications of AT&T Pub 62310 is present at the RTIP and RRING inputs during the entire initialization process. The RPOS/RNEG outputs are not valid until full operation is achieved. During offset cancellation, the RPOS/RNEG outputs do not adhere to the AMI rule. However, once initialized (assuming that a proper baud rate is selected), RPOS and RNEG outputs are never simultaneously High.

#### 2.2.1 Reset

A hardware reset is required after any of the following changes in transceiver configuration:

- 1. A change in Data Rate setting.
- 2. A change in the local analog loopback configuration.
- 3. A local change in the line upon which the transceiver is communicating (for example, configurations for changing lines in a "1 for n" redundancy scheme).



**Table 2. Data Rate Programming** 

FP4	FP3	FP2	FP1	Data Rate <sup>1</sup>
Low	Low	Low	Low	2.4 kbps
Low	Low	Low	High	3.2 kbps
Low	Low	High	Low	4.8 kbps
Low	Low	High	High	6.4 kbps
Low	High	Low	Low	9.6 kbps
Low	High	Low	High	12.8 kbps
Low	High	High	Low	19.2 kbps
Low	High	High	High	25.6 kbps
High	Low	Low	Low	56.0 kbps
High	Low	Low	High	72.0 kbps
High	Low	High	Low	3.5 kbps
High	Low	High	High	7.0 kbps
High	High	Low	Low	14.0 kbps
High	High	Low	High	28 kbps
Low	RCLK <sup>1</sup>	Low	Low	38.4 kbps
Low	RCLK <sup>1</sup>	Low	High	51.2 kbps
Low	RCLK <sup>1</sup>	High	Low	64.0 kbps

<sup>1.</sup> These data rates are activated when RCLK output on pin 8 is applied to the FP3 input on pin 11.

**Table 3. Ones Density Requirements** 

Data Rate (kbps)	Minimum Average Ones Density
2.4, 4.8, 9.6, 19.2, 38.4	1 / 12
3.2, 6.4, 12.8, 25.6, 51.2	1 / 16
56.0	1 / 14
64.0	1 / 16
72.0	1 / 18
3.5, 7.0, 14.0, 28.0	≈ 1 / 16

Automatic re-initialization may be triggered by changes in received signal strength as follows:

- If received signal strength increases by more than about 6 dB after full operation is achieved, automatic re-initialization occurs.
- If received signal strength decreases by more than about 4 dB, re-initialization occurs. If the decrease in received signal strength exceeds 6 dB, the LXT400 reports an LOS condition and performs an automatic re-initialization.



The time required to achieve full operation after re-initialization, is the same as required for power-on initialization (i.e., 1 second max with 50% ones density, 8 seconds under minimum ones density conditions). Re-initialization is not triggered by impulse noise events.

#### 2.3 Transmission

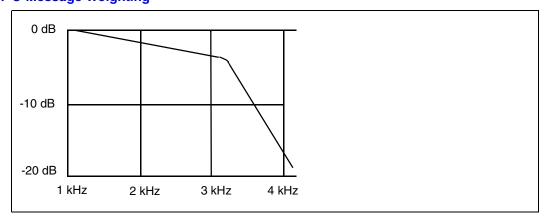
TPOS and TNEG must have transitions coincident with the rising edges of TCLK. The transmit section generates a 50% AMI pulse according to the pulse encoding rules, which is synchronized with the TCLK input. In DSU applications, RCLK is typically routed back into the TCLK input. The instantaneous baud period varies with the receive DPLL phase adjustments, however, the pulse duty cycle is maintained at 50% of the nominal baud period by internal re-synchronization to TCLK. The AMI pulse is then processed through a set of frequency dependent filters.

Initial filtering at all rates is accomplished by a programmable, switched-capacitor, low-pass filter. This filter is a single-pole type with the pole set at 1.3 times the bit rate (as determined by inputs FP1 - FP4).

For data rates of 2.4, 3.2, 4.8, 6.4, 9.6 and 12.8 kbps, the filtered pulses go through an additional low-pass notch filter. The notch filter is required to protect other DDS services with specific band requirements, and provides the attenuation listed in Table 4. The additional rejection requirement is weighted within each band by "C-Message" weighting over double speech sidebands around a carrier in the middle of each band (28 kHz and 76 kHz). The C-Message weighting function is graphed in Figure 2. Depending on the data rate, the frequency template extends to different limits as shown in Table 5. (An alternate notch filter is used for data rates of 3.5 and 7.0 kbps.) The single pole, low-pass filter would maintain the frequency within  $\pm$  5%. The notch filter attenuation is added to this.

A continuous filter, common to all data rates, is the final stage. The continuous filter removes high frequency components which remain after processing by the low-pass filter stages. The pulse is then applied to the line driver for transmission onto the twisted-pair line.

Figure 3. C-Message Weighting





OCU/Loop	Customer (Primary Channel) Data Rate (kbps)	Rejection	Band
Data Rate (kbps)	Data nate (KDPS)	22 - 32 kHz	72 - 80 kHz
2.4 or 3.2	2.4	5 dB	1 dB
4.8 or 6.4	4.8	13 dB	9 dB
9.6 or 12.8	9.6	17 dB	8 dB

**Table 4. Notch Filter Attenuation** 

#### 2.4 Reception

RTIP and RRING inputs are differentially detected, then processed through the pre-filters and equalizer section. The continuous pre-filter removes high frequency noise and prevents aliasing problems for the switched capacitor (SC) line equalizers which follow. Pulse reshaping is achieved by the receive equalizer, which consists of an SC step equalizer and an adaptive decision feedback equalizer (DFE). The DFE eliminates residual inter-symbol interference (ISI) due to echoing by multiple bridged tap connections and the quantized frequency responses of the SC step filters. The DFE is continuously adapted to compensate for ISI due to time-varying line characteristics such as temperature, humidity and age. Nine different filter selections based on signal strength are available.

#### 2.4.1 Changes in Received Signal Strength

During initialization, the LXT400 selects filters appropriate to the strength of the received signal. After initialization, the LXT400 continually monitors the receive signal strength to ensure the optimum signal/filter match. Data reception is not affected by impulsive noise events or by slow changes in signal amplitude, such as may be caused by temperature and humidity changes on the line. (The maximum constant rate of change which the LXT400 can track is 6 dB per minute.) However, instantaneous "step" changes (Figure 3) may temporarily interfere with data reception. Step changes may be due to sudden changes in loop loss, far end transmitter output, etc.

After normal operation has been established, an instantaneous single-step change may cause one of three conditions, as shown in Figure 4.

Under Condition 1, the LXT400 automatically adapts to minor step changes in signal strength (assuming that the new input is a valid DDS signal).

Under Condition 3, the LXT400 responds to significant step changes by re-initializing.

Condition 2, while unlikely to occur in an actual DDS implementation, may be observed in the laboratory due to artificial line simulators. Condition 2, which results from a 6 - 20 dB step increase in received signal strength, may result in a signal/filter mismatch. This condition is characterized by excessive bipolar violations (BPVs) which can be observed on RPOS and RNEG. External signal quality detection circuitry can be used to detect excessive BPVs that are not recognized as standard DDS BPV code words. Upon detection of unrecognized BPVs, the user may force a reset on the LXT400 to resume error-free operation.

Under normal operating conditions, step changes in received signal strength are all under local control. Thus, the user can reset the LXT400 once the new receive signal has stabilized at the chip inputs. Remote changes typically involve disconnecting one line and re-connecting another line of

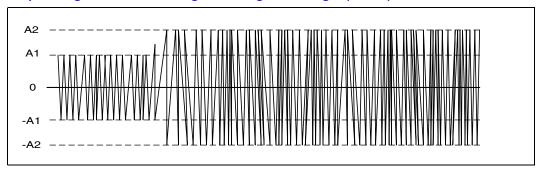


different length. These changes trigger the RLOS report and automatic re-initialization. Any remote changes in line length or transceiver configuration are beyond the local user's control. Remote changes in data rate are not detected

Table 5. Frequency Limits per Data Rate

Data Rate (kbps)	Upper Frequency Limit (kHz)
2.4 (3.2)	100
4.8 (6.4)	150
9.6 (12.8)	150
19.2 (25.6)	150
38.4 (51.2)	150
56.0 (72.0)	150
64.0	150
3.5	100
7.0	150
14.0	150
28.0	150

Figure 4. Step Changes in Received Signal Strength = 20 log10(A2/A1) dB



#### 2.4.2 Receive Loss of Signal

RLOS goes High when more than 32 consecutive zeros are received, caused either by a true loss of signal, or a signal strength drop greater than 6 dB. The LXT400 automatically re-initializes when RLOS goes High, and 40 consecutive zeros are counted. Figure 5 shows the RTIP/RRING input and RLOS output timing relationships for a true loss of signal. When signal energy returns to the chip input, the LXT400 executes one full activation cycle in the presence of this signal. The result is that RLOS will remain High for a period of time (0.13 s < tH < 16 s) after signal energy reappears.

Figure 6 shows the RTIP/RRING input timing and RLOS output timing relationship for a signal strength decrease greater than 6 dB. In this case, RLOS will go High for a time 0.26 s < tP < 16 s.



Condition 3 Condition 1 Condition 1 Condition 2 Condition 3 0 dB +16 +20 -10 -8 -2 +3 +6 +10 +30 -12 Reference Signal Level Condition 3: > 20 dB Increase or > 6 Condition 1: 0 - 6 dB Increase or Decrease. Condition 2: 6 - 20 dB Increase. dB Decrease. Automatic compensation (may re-initialize). Re-initialization not guaranteed. The Automatic re-initialization. No action May pass erroneous data temporarily before device may continue to pass required. If the condition is due to a resuming error-free performance. No action erroneous data until reset. RESET signal strength decrease, the LXT400 pulse required to ensure accurate data required. also reports RLOS. reception.

Figure 5. Conditions Based on Changes in Received Signal Strength

Figure 6. RLOS Timing for a True Loss of Signal

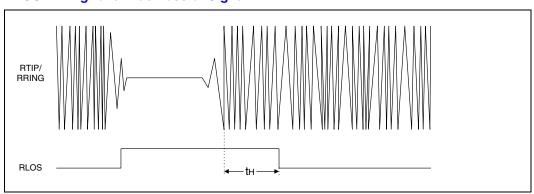
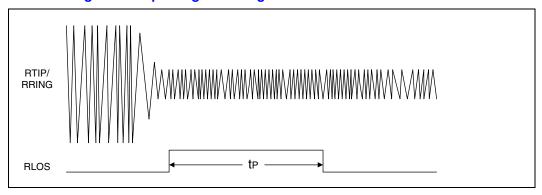


Figure 7. RLOS Timing for a Drop in Signal Strength > 6 dB





#### 2.4.3 Timing Recovery

The timing recovery circuit uses a rate synchronizer to generate a high frequency internal clock from the MCLK input. A DPLL is used to synchronize this internal clock to the received data pulses. The output clock from the DPLL is divided down to generate RCLK and all other required clocks (except TCLK which is an external input).

#### 2.4.4 Data Extraction

The data extraction block provides RPOS and RNEG outputs. A positive differential pulse received between RTIP and RRING results in a High on RPOS. A negative differential pulse between RTIP and RRING results in a High on RNEG. RPOS and RNEG are output at the received data rate and are valid on the falling edge of RCLK.

Receiver operation is not affected by the data patterns, provided the ones density requirements of Table 3 are met with no more than 26 consecutive zeros. RLOS is declared after 32 consecutive zeros. However, the RCLK output remains synchronized to the RTIP/RRING input for up to 40 consecutive zeros, after which re-initialization occurs. Bipolar violations are received properly. The bipolar violation coding rule that successive violations be of alternating polarity must be followed. However, if this rule is temporarily broken (due to channel noise, etc.), long term LXT400 data reception will not be adversely affected.

#### 2.5 Loopback Operation

When the LPBK pin is set High, the recovered data and clock are sent back through the transmit section and onto the line interface, as well as being output on the RPOS/RNEG and RCLK pins. TPOS/TNEG and TCLK inputs are ignored in the loopback mode.

## 2.6 Serial Port Operation

The line status (LS) output is an 8-bit or 16-bit serial word enabled by pulling  $\overline{LSE}$  Low for 8 or 16 bit-periods as shown in Figure 13 and Figure 14. Refer to Test Specifications for Serial Port Timing. Bit assignments are listed in Table 6. Approximate line loss and loop length (based on received signal strength/filter selection, assuming far-end pulse transmission compliant with AT&T Pub 62310 or T1E1/90-051) are reported via bits b0 through b3 as listed in Table 7. When combined with the receive signal magnitude bits in positions b8-b15, the line attenuation may be calculated to within  $\pm 1$  dB of actual value using the following equation:

Insertion loss value in dB from Table 7 based on LL3-LL0 value. 
$$+20 \text{ Log}_{10} \left( \frac{3c \text{ hex}}{\text{Mag} < 7:0 > \text{hex}} \right); dB$$

Bits b4 through b6 indicate the receiver activation state. Bit b7 is the RLOS alarm.

Figure 8 shows the serial output for a typical LXT400 initialization sequence. Bits b0 - b3 report filter selection and bits b4 - b6 report receiver status. Bit b6 toggles to indicate that the receiver is alternating between offset cancellation (b6 - b4 = 100) and receive level detection (b6 - b4 = 000). The receiver starts with the highest-gain filter (b3 - b0 = 0111), cancels systematic voltage offset at



the filter output, and then detects the receive signal level at the filter output. If the signal exceeds the threshold for that filter, the LXT400 steps down to the filter with the next-highest gain (b3 - b0 = 1000). This process is repeated until the receive signal level does not exceed the filter threshold.

Once the appropriate filter is selected, the receiver phase locked loop (PLL) and slicer levels converge to match the receive signal for optimum SNR. During receiver convergence (b6 - b4 = 001), the PLL adapts to sample the peak of the receive pulses and the slicer level adapts to the midway point between zero and the pulse peak voltage. Once convergence is complete, the LXT400 begins full operation (b6 - b4 = 010).

Figure 8. Typical Serial Port Output for Receive Activation @ 72 kbps

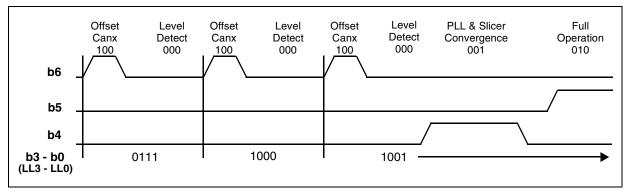


Table 6. LS Word Bit Assignments

Bit #	Name	Description	Bit #	Name	Description
b0	LL0	Loop Length Indication, bit 0	b8	MAG0	Rx signal magnitude bit 0
b1	LL1	Loop Length Indication, bit 1	b9	MAG1	Rx signal magnitude bit 1
b2	LL2	Loop Length Indication, bit 2	b10	MAG2	Rx signal magnitude bit 2
b3	LL3	Loop Length Indication, bit 3	b11	MAG3	Rx signal magnitude bit 3
b4	S1	Receiver Converging when High	b12	MAG4	Rx signal magnitude bit 4
b5	S2	Full Operation when High	b13	MAG5	Rx signal magnitude bit 5
b6	S0	Level Detection when High	b14	MAG6	Rx signal magnitude bit 6
b7	RLOS	Receive Loss of Signal when High	b15	MAG7	Rx signal magnitude bit 7



Table 7. LS Loop Length Bits LL3 - LL0

Rate kbps	Ontimum receiver slicer level, with $M\Delta(4) = 30$ hex									
	0111	1000	1001	1010	1011	1100	1101	1110	1111	
2.4	N/A	42.3 / 23	36.0 / 19.2	30.0 / 15.3	24.2 / 11.5	20.0 / 8.6	15.5 / 5.0	10.6 / 2.4	3.4 / 0.8	
3.2	N/A	42.0 / 19.9	36.0 / 16.9	30.7 / 14.3	25.2 / 11.6	20.0 / 7.8	15.0 / 4.9	10.3 / 2.4	3.0 / 0.7	
4.8	N/A	42.3 / 17.3	36.3 / 14.7	30.5 / 12.0	24.7 / 9.3	18.8 / 6.7	13.5 / 4.0	9.3 / 2.0	3.1 / 0.7	
6.4	N/A	42.4 / 15.4	36.5 / 13.2	31.2 / 11.0	25.6 / 8.8	20.0 / 6.6	15.0 / 4.4	10.0 / 2.2	3.3 / 0.7	
9.6	N/A	40.0 / 12.5	35.0 / 10.7	29.6 / 8.9	24.2 / 7.1	18.9 / 5.4	13.8 / 3.6	9.0 / 1.8	2.5 / 0.5	
12.8	N/A	42.3 / 11.7	36.2 / 10.0	30.7 / 8.3	25.0 / 6.7	19.3 / 5.0	13.8 / 3.3	8.8 / 1.7	2.6 / 0.5	
19.2	N/A	42.2 / 10.0	36.2 / 8.6	30.5 / 7.1	24.9 / 5.7	14.0 / 4.3	13.0 / 2.9	7.7 / 1.4	1.0 / 0.2	
25.6	N/A	42.0 / 9.0	36.0 / 7.7	30.2 / 6.4	24.5 / 5.1	18.4 / 3.9	13.6 / 2.6	7.5 / 1.3	0.5 / 0.1	
38.4	N/A	42.5 / 8.4	36.5 / 7.1	30.7 / 6.0	25.0 / 4.7	18.9 / 3.6	14.0 / 2.4	7.4 / 1.2	1.0 / 0.2	
51.2	N/A	43.0 / 7.7	37.0 / 6.6	31.2 / 5.5	25.5 / 4.4	19.4 / 3.3	14.0 / 2.2	7.4 / 1.1	0.5 / 0.1	
56.0	50.5 / 8.5	44.4 / 7.5	38.4 / 6.4	32.3 / 5.3	26.0 / 4.2	19.7 / 3.2	13.6 / 2.1	7.3 / 1.1	0.0 / 0.0	
72.0	50.7 / 8.0	45.0 / 7.0	38.8 / 6.0	32.5 / 5.0	26.3 / 4.0	20.0 / 3.0	14.0 / 2.0	7.4 / 1.0	0.0 / 0.0	
64.0	50.0 / 8.3	44.0 / 7.2	38.0 / 6.2	32.0 / 5.3	26.0 / 4.1	19.7 / 3.1	14.0 / 2.1	7.4 / 1.1	0.0 / 0.0	
3.5	N/A	43.0 / 20.4	37.4 / 17.3	31.5 / 14.2	26.0 / 11.2	20.2 / 8.1	15.0 / 5.0	10.3 / 2.5	4.1 / 1.0	
7.0	N/A	43.8 / 15.4	37.8 / 13.2	32.3 / 11.0	26.4 / 8.8	20.5 / 6.6	15.0 / 4.4	10.0 / 2.2	3.6 / 0.8	
14.0	N/A	43.0 / 11.7	37.5 / 10.1	31.9 / 8.34	25.6 / 6.67	19.8 / 5.0	13.9 / 3.3	8.5 / 1.7	2.5 / 0.5	
28.0	N/A	43.7 / 9.0	37.5 / 7.7	31.9 / 6.4	25.7 / 5.1	19.5 / 3.9	13.0 / 2.6	7.5 / 1.3	0.5 / 0.1	
NOTE	: A MAC	37 - MAG0 valı	ue of 3C hex re	presents a 1V	slicer level at tl	he point of rec	eive data dete	ection.		



## 3.0 Application Information

#### 3.1 Introduction

Figure 9 shows a typical LXT400 application circuit. A DSU crystal (4.096 MHz) is connected across MCLK1 and MCLK2, with two grounded loading capacitors. The line interface consists of a pair of 1:1 transformers, center-tapped on the line side, with appropriate load resistors. The Rs/Cs shunt network provides high frequency compensation for the transmit driver. The input signal is developed across the Rr/Rin network. Rv limits current into the low-impedance VINT driver during over-voltage conditions on the line. Table 8 lists external component recommendations.

#### 3.2 Crosstalk

It is important to prevent crosstalk between the transmitter and receiver circuits. Steps were taken to reduce this interference inside the LXT400, but precautions must be taken with the line interface circuitry outside the chip as well. Crosstalk is especially high when the idle pattern (alternate positive and negative pulses) is being transmitted because the transmit power is concentrated around the Nyquist frequency (half the baud rate).



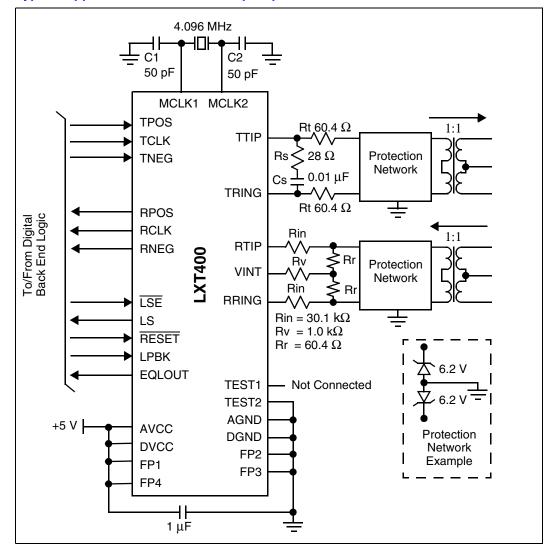


Figure 9. Typical Application Circuit for 72 kbps Operation

## 3.3 PCB Layout

The external line interface circuit must be laid out to minimize coupling of other digital and analog signals into RTIP and RRING (Figure 10). These inputs, pins 2 and 3, are high impedance nodes which can pick up interference from adjacent PCB traces. The line interface circuit must be designed for loops with up to 50 dB of loss at the Nyquist frequency, even if the product will never be used on such long lines. When no receive signal is present, the LXT400 will switch to the highest gain filter, which at 56, 64 and 72 kbit/s produces an internal gain of about 50 dB. Unless precautions are taken, substantial interference coupling into RTIP and RRING could exceed the internal slicer levels and prevent the RLOS report. Layout considerations for LXT400 application circuits include:

 Minimum PCB trace lengths between the LXT400 and the 4.096 MHz crystal and loading capacitors.



- Minimum PCB trace lengths between resistors Rin and the RTIP and RRING pins. Shield these connections with ground traces.
- Minimum PCB trace lengths between the receive transformer and the receive termination network.

Even with good PCB layout practices, RLOS reporting can be unreliable if the twisted pair line cable is not connected to the OCU or CSU/DSU when the LXT400 is set for operation at 56, 64, or 72 kbit/s. The unterminated receive lines can pick up enough noise to trip the data detectors and force RLOS Low. However, equipment designers can safely assume that the highest-gain filter with 50 dB of signal amplification will never be selected for normal operation on lines with up to 45 dB of attenuation at the Nyquist frequency. Therefore, the status word on the LS output can be used as a secondary LOS indicator - the occurrence of RLOS=0 and LL3-0 = 0111 at 56, 64 or 72 kbps reliably indicates the loss of carrier condition.

The 50dB filters were designed for applications in which the line attenuation is 48 dB or greater. The DDS specification requires an insertion loss at 56, 64, and 72 kbit/s of 43 dB or less. The LXT400 incorporates built-in headroom up to 45 dB. So for standard applications, the highest-gain filter will never be selected. The critical element is operating frequency. The highest gain filter (50 dB) is only available at 56, 64, and 72 kbit/s settings. At the lower operating frequencies, the highest-gain filter is about 44 dB, well above the interference levels arising from unterminated lines.

**Ground Trace** Rr Line Protection Circuitry Transformer **LXT400** Q Q Q <u>D</u>1 VINT Rr Rin O 2 **RTIP** Rin **O** 3 **RRING Ground Trace** 

Figure 10. Suggested LXT400 PCB Layout



**Table 8. External Component Recommendations** 

Component	Parameter	Recommended Value		
	Turns ratio	1:1, ± 1%		
Line Transformer	Structure	Center tapped (line side only)		
Line Transformer	Primary Inductance	200 mH minimum		
Suggested Manufacturers	Leakage Inductance	22 to 43 μH maximum		
Midcom - Phone 800/643-2661	Interwinding Capacitance	350 pF maximum		
Schott - Phone 615/889-8800	DC Resistance (Primary, Rwp)	7 to 15 Ω		
	DC Resistance (Secondary, Rws)	7 to 15 $\Omega$ , See Rt, Rr calculation		
Rin	Resistance, Tolerance, Rating	30.1 kΩ, ± 1%, 1/4 W		
Rt, Rr	Resistance, Tolerance, Rating	(135 Ω - Rwp - Rws) / 2, ± 1%, 1/4 W		
Rv	Resistance, Tolerance, Rating	1 kΩ, ± 5%, 1/4 W		
	Nominal frequency	4.096 MHz		
	Holder style	HC-49/U		
DSU Crystal	Operating Mode	Fundamental, parallel resonant		
Doo orystal	Load Capacitance	28 pF nominal		
Suggested Manufacturers	Tolerance	± 35 ppm @ 25 °C		
Fox - Phone 813/693-0099	Range	± 50 ppm, -40 to 85 °C		
Monitor - Phone 815/432-5296	Aging	3 ppm per year maximum		
	Maximum ESR	120 Ω		
	Drive Level	1 mW maximum		
DCLI Crystal Loading Conscitors	Capacitance, Tolerance, Rating	50 pF, ±5%, 10 V		
DSU Crystal Loading Capacitors	Construction	NPO ceramic or equivalent		
Transmit Shunt Network				
Rs	Resistance, Tolerance, Rating	28 Ω, ± 5%, 1/4 W		
Cs	Capacitance, Tolerance, Rating	0.01 μF, ± 20%, 10 V		



## 4.0 Test Specifications

**Note:** The minimum and maximum values in Table 9 through Table 13 and Figure 11 through Figure 15 represent the performance specifications of the LXT400 and are guaranteed by test, except where noted by design.

**Table 9. Absolute Maximum Ratings** 

Parameter		Minimum	Maximum	Units
	AVCC referenced to AGND	-0.3	6.0	V
DC Supply	DVCC referenced to DGND	-0.3	6.0	V
DC Supply  DVCC referenced to AVCC  DGND referenced to AGND		-0.3	0.3	V
		-0.3	0.3	V
Input Voltage,	any pin <sup>1,2</sup>	AGND - 0.3	AVCC + 0.3	V
Input or outpu	t diode current, any pin <sup>2</sup>	-	±20	mA
Continuous output current, any pin <sup>2</sup>		-	±25	mA
Continuous current, VCC or GND pins		-	±60	mA
Storage Temp	erature	-40	±150	°C

**Caution:** Exceeding these values may cause permanent damage. Functional operation under these conditions is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

**Table 10. Recommended Operating Conditions and Characteristics** 

Parameter	Sym	Min	Тур	Max	Units
DC supply	AVCC/DVCC	4.75	5.0	5.25	V
Ambient operating temperature	TA	-40	-	85	° C

Table 11. DC Electrical Characteristics (Under Recommended Operating Conditions)

Parameter	Sym	Min	<b>Typ</b> <sup>1</sup>	Max	Units	Test Conditions
Supply current (transmitting spaces)	Icc	-	40	60	mA	270 $\Omega$ resistor across TTIP and TRING
Supply current (transmitting all marks)	Icc	-	47.5	60	mA	270 $\Omega$ resistor across TTIP and TRING
Input Low voltage	VIL	-	-	0.8	٧	Digital inputs
Input High voltage	VIH	2.0	-	_	٧	Digital inputs
Output Low voltage	Vol	-	-	0.4	٧	IOL = 1.6 mA
Output Low voitage	VOL	_	0.2	_	٧	IOL < 10 μA
1. Typical figures are at 25 °C and are for d	lesign aid only	/; not gua	ranteed a	nd not su	bject to pro	duction testing.

<sup>1.</sup> TTIP and TRING are referenced to DVCC and DGND.

<sup>2.</sup> Except DC supply pins.



Table 11. DC Electrical Characteristics (Under Recommended Operating Conditions) (Continued)

Parameter	Sym	Min	Typ <sup>1</sup>	Max	Units	Test Conditions	
Output High voltage	Vон	2.4	-	_	V	IOH = 0.4 mA	
Output High voltage	VOH	_	4.5	_	μΑ	IOH < 10 μA	
Input leakage current	lıL	-40	_	40	μΑ	0 < VIN < Vcc	
1. Typical figures are at 25 °C and are for design aid only; not guaranteed and not subject to production testing							

#### **Table 12. AC Electrical Characteristics**

Parameter		Sym	Min	Typ <sup>1</sup>	Max	Units
Input capacitance		Cin	_	7	_	pF
TCLK jitter at DSU with respect to RCLK		tJIT	_	_	2	% tpr at DSU
RCLK isochronous distortion at DSU		rJIT	_	_	5	% tpt at OCU
Transmit output jitter with respect to TCLK		OJIT	_	_	3	% tpt at DSU
Transmit pulse amplitude at	at 9.6 and 12.8 kbps	Ат	1.44	1.55	1.75	V
TTIP/TRING <sup>2</sup>	at all other rates	Ат	2.56	2.74	2.92	V

**Table 13. Timing Characteristics** 

Parameter		Min	$\mathbf{Typ}^1$	Max	Unit
RCLK period	tPR	-	1/fb	-	ns
RCLK pulse width High	trwh	1/ (2 fb) -150	1/ (2 fb)	1/(2 fb)+150	ns
RPOS/RNEG delay from RCLK rising edge <sup>2</sup>	tDP	_	_	200	ns
Transition time on any digital output <sup>2</sup>	tто	-	10	20	ns
TCLK period	tPT	_	1/ fb	_	μs
TCLK pulse width High  Transmit Timing  TPOS/TNEG setup time to TCLK falling edge		400	_	_	ns
		200	-	_	ns
TPOS/TNEG hold time from TCLK falling edge	tтн	200	-	_	ns
Transition time on any digital input	tΤι	_	_	40	ns
TCLK frequency tolerance	fttol	-50	0	+50	ppm
LS delay from RCLK falling edge <sup>2</sup>	tLSP	_	_	200	ns
LSE setup to RCLK rising edge	tLSU	200	_	_	ns
LSE hold time from RCLK rising edge	tLSH	trwh	_	-	ns
LSE Low to low Z state	tLZ	-	_	100	ns
LSE High to high Z state	tHZ	-	-	100	ns
	RCLK period  RCLK pulse width High  RPOS/RNEG delay from RCLK rising edge <sup>2</sup> Transition time on any digital output <sup>2</sup> TCLK period  TCLK pulse width High  TPOS/TNEG setup time to TCLK falling edge  TPOS/TNEG hold time from TCLK falling edge  Transition time on any digital input  TCLK frequency tolerance  LS delay from RCLK falling edge <sup>2</sup> LSE setup to RCLK rising edge  LSE hold time from RCLK rising edge  LSE Low to low Z state	RCLK period tpm RCLK pulse width High triwn RPOS/RNEG delay from RCLK rising edge² tdp Transition time on any digital output² tto TCLK period tpm TCLK pulse width High ttwh TPOS/TNEG setup time to TCLK falling edge ttru Transition time on any digital input ttru TCLK frequency tolerance fttoL LS delay from RCLK falling edge tLSP  LSE setup to RCLK rising edge tLSU  LSE hold time from RCLK rising edge tLSU  LSE Low to low Z state ttri  TRIWH TRIWH TOUR frequency tolerance fttoL LSD tLSD tLSD tLSD tLSD tLSD tLSD tLSD t	RCLK period tpm   tpm	RCLK period transfer to the transfer transfer to the transfer tran	RCLK period         tPR         -         1/fb         -           RCLK pulse width High         tRWH         1/ (2 fb) -150         1/ (2 fb) +150         1/(2 fb) +150           RPOS/RNEG delay from RCLK rising edge²         tDP         -         -         200           Transition time on any digital output²         tTO         -         10         20           TCLK period         tPT         -         1/ fb         -           TCLK pulse width High         tTWH         400         -         -           TPOS/TNEG setup time to TCLK falling edge         tTSU         200         -         -           TPOS/TNEG hold time from TCLK falling edge         tTH         200         -         -           Transition time on any digital input         tTI         -         40           TCLK frequency tolerance         fTTOL         -50         0         +50           LS delay from RCLK falling edge²         tLSP         -         -         200           LSE setup to RCLK rising edge         tLSH         tRWH         -         -           LSE Low to low Z state         tLZ         -         -         100

<sup>1.</sup> Typical figures are at 25 °C and are for design aid only; not guaranteed and not subject to production testing.

<sup>1.</sup> Typical figures are at 25 °C and are for design aid only; not guaranteed and not subject to production testing. 2. The instantaneous peak amplitude of an isolated pulse (i.e. a mark between two spaces) into a 270  $\Omega$  resistive load.

<sup>2.</sup> Measured with 15pf load.

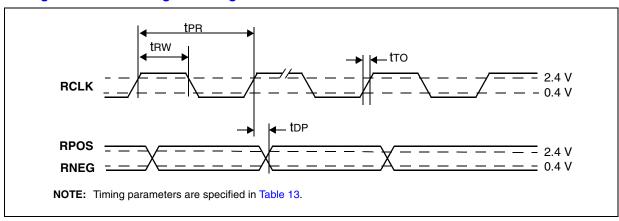


**Table 13. Timing Characteristics (Continued)** 

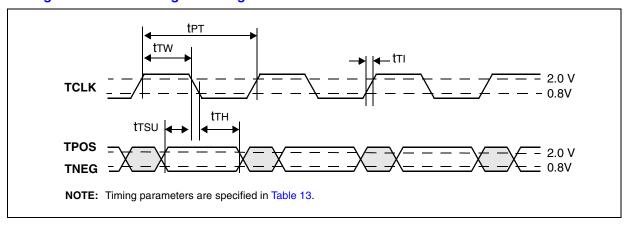
	Parameter	Sym	Min	Typ <sup>1</sup>	Max	Unit
MOLICO	MCLK1 input frequency	fMCLK	_	4.096	-	MHz
MCLK & RESET	MCLK1 frequency tolerance	fMTOL	-100	0	+100	ppm
Timing Figure 15	MCLK1 pulse width High	tmwH	98	122	146	ns
92.0 10	RESET pulse width Low	tRWL	1000	I	-	ns

<sup>1.</sup> Typical figures are at 25 °C and are for design aid only; not guaranteed and not subject to production testing.

**Figure 11. Receive Digital Timing** 



**Figure 12. Transmit Digital Timing** 



<sup>2.</sup> Measured with 15pf load.



Figure 13. LS Serial Port Timing - 8-Bit Word

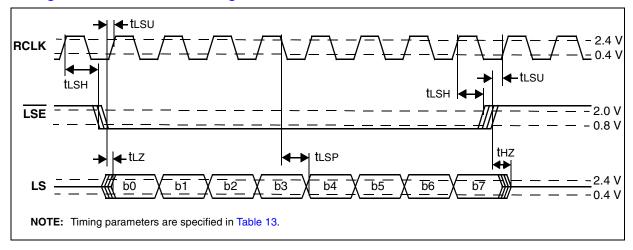


Figure 14. LS Serial Port Timing - 16-Bit Word

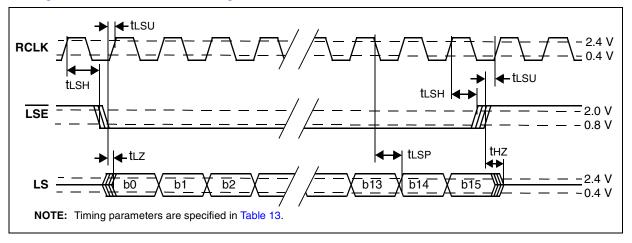
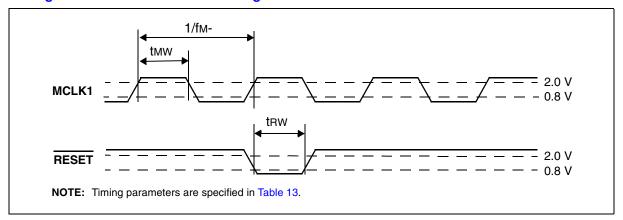


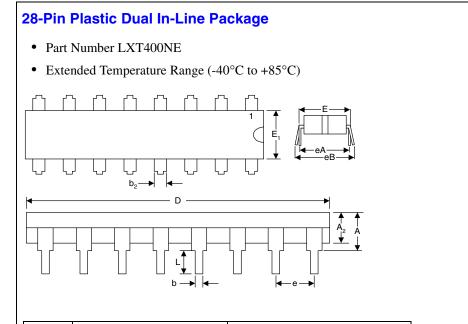
Figure 15. MCLK and RESET Timing





## 5.0 Mechanical Specifications

Figure 16. LXT400NE Package Specification



Dim	Inc	hes	Millim	neters
Dilli	Min	Max	Min	Max
Α	_	0.250	-	6.350
A2	0.125	0.195	3.175	4.953
b	0.014	0.022	0.356	0.559
b2	0.030	0.070	0.762	1.778
D	1.380	1.565	35.052	39.751
E	0.600	0.625	15.240	15.875
E1	0.485	0.580	12.319	14.732
е	0.100 BSC	(nominal)	2.540 BSC	(nominal)
eA	0.600 BSC	(nominal)	15.240 BSG	(nominal)
eB	_	0.700	_	17.780
L	0.115	0.200	2.921	5.080

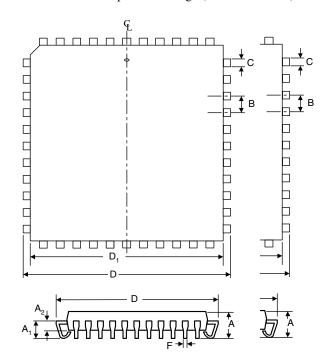
BSC: Basic Spacing between Centers



Figure 17. LXT400PE Package Specification

## 28-Pin Plastic Leaded Chip Carrier

- Part Number LXT400PE
- Extended Temperature Range (-40°C to +85°C)



Dim	Inc	hes	Millimeters		
Dim	Min	Max	Min	Max	
Α	0.165	0.180	4.191	4.572	
A1	0.090	0.120	2.286	3.048	
A2	0.062	0.083	1.575	2.108	
В	.050 BSC	(nominal)	1.27 BSC	(nominal)	
С	0.026	0.032	0.660	0.813	
D	0.485	0.495	12.319	12.573	
D1	0.450	0.456	11.430	11.582	
F	0.013	0.021	0.330	0.533	

BSC: Basic Spacing between Centers